

Network Analysis

是德科技專案經理

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Agenda

- Transmission Lines and S-Parameters
- Network Analyzer Block Diagram
- Network Analysis Measurements
- Calibration and Error Correction



Transmit Receive Design Challenges



End goal: maximize link budget, fidelity & efficiency



Why Do We Need to Test Components?

 Verify specifications of "building blocks" for more complex RF systems



- Ensure distortion less transmission of communications signals
 - Linear: constant amplitude, linear phase / constant group delay
 - Nonlinear: harmonics, intermodulation, compression, X-parameters
- Ensure good match when absorbing power (e.g., an antenna)





The Need for Both Magnitude and Phase

- 1. Complete characterization of linear networks
- 2. Complex impedance needed to design matching circuits

3. Complex values needed for device modeling





6. X-parameter (nonlinear) characterization

Pre-distortion



Mixer Measurement is simplified with UI

SUPPORTS SINGLE AND DUAL STAGE CONVERTERS.

| Sweep | Power | Mixer Frequency | Mixer Power | Mixer Setup | | | 0 |
|-------|-----------|------------------|-------------|------------------------------------|-----------------|--------------------|----|
| Conve | rter Stag | es: 2 • | F | lardware Configura Port 3: Thru | ation | Add Source | |
| Conve | erter Mod | el: Single Stage | F | Port 4: Thru | | Path Configuration | |
| Port | : 1 | - X | 1 v 1 v | ->- | | Port 2 • | |
| | | | | | \times | | |
| | | | LO1: M | ⟨G + | LO2: Not contro | olled • | |
| | | | | | | | |
| Cauco | | beal | | OK | Canaal | Apply | lo |



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RF Energy Transmission





Transmission Line Basics

- Low Frequencies
 - Wavelengths >> wire length
 - Current (I) travels down wires easily for efficient power transmission
 - Measured voltage and current not dependent on position along wire



- High Frequencies
 - Wavelength ~ or << length of transmission medium
 - Need transmission lines for efficient power transmission
 - Matching to characteristic impedance (Zo) is very important for low reflection and maximum power transfer
 - Measured envelope voltage dependent on position along line



Transmission line Z_o

- Z_o determines relationship between voltage and current waves
- Z_o is a function of physical dimensions and ε_r
- Z_o is usually a real impedance (e.g. 50 or 75 ohms)



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Component Test Fundamentals

High-frequency Device Characterization





Reflection Parameters



Smith Chart Review

 $\rho_{L} \Phi$





Characterizing Unknown Devices

USING PARAMETERS (H, Y, Z, S) TO CHARACTERIZE DEVICES

- Gives linear behavioral model of our device
- Measure parameters (e.g. voltage and current) versus frequency under various source and load conditions (e.g. short and open circuits)
- Compute device parameters from measured data
- Predict circuit performance under any source and load conditions

 $\begin{array}{ll} \underline{\textit{H-parameters}} & \underline{\textit{Y-parameters}} \\ V_1 = h_{11}I_1 + h_{12}V_2 & I_1 = y_{11}V_1 + y_{12}V_2 \\ I_2 = h_{21}I_1 + h_{22}V_2 & I_2 = y_{21}V_1 + y_{22}V_2 \\ (Hybrid) & (Admittance) \end{array}$

 $\frac{Z - parameters}{V_1 = Z_{11}I_1 + Z_{12}I_2}$ $V_2 = Z_{21}I_1 + Z_{22}I_2$ (Impedance)

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 $h_{11} = \frac{V_1}{I_1} \Big|_{V_2=0}$ (1) $h_{12} = \frac{V_1}{V_2} \Big|_{I_1=0}$ (1)

(requires short circuit)

(requires open circuit)



Why Use Scattering, S-Parameters?

- Relatively easy to obtain at high frequencies
 - Measure voltage traveling waves with a vector network analyzer
 - Don't need shorts/opens (can cause active devices to oscillate or self-destruct)
- Relate to familiar measurements (gain, loss, reflection coefficient ...)
- Can cascade S-parameters of multiple devices to predict system performance
- Can compute H-, Y-, or Z-parameters from S-parameters if desired
- Can easily import and use S-parameter files in electronic-simulation tools





Measuring S-Parameters





Equating S-Parameters With Common Measurement Terms



 S_{11} = forward reflection coefficient *(input match)* S_{22} = reverse reflection coefficient *(output match)* S_{21} = forward transmission coefficient *(gain or loss)* S_{12} = reverse transmission coefficient *(isolation)*

Remember S-parameters are inherently complex, linear quantities – however, we often express them in a log-magnitude format



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Generalized Network Analyzer Block Diagram

FORWARD MEASUREMENTS SHOWN





Component Test Fundamentals

Source

Source stimulus can sweep frequency or power or phase

 Modern NAs may have the option for a second internal source and/or the ability to control external source

Used for driving differential devices Can control an internal or external source as a local oscillator (LO) signal for mixers and converters Useful for mixer measurements like conversion loss, group delay

For more information on converter testing: http://www.keysight.com/upload/cmc_upload/All/PNA_Advances_Converter_Testing.pdf





KEYSIGHT TECHNOLOGIES

Signal Separation

- Measure incident signal for reference
- Separate incident and reflected signal







Directional Coupler & Directivity



 Directivity is a measure of how well a directional coupler or bridge can separate signals moving in opposite directions





Interaction of Directivity with the DUT

(WITHOUT ERROR CORRECTION)







- Provides harmonic / spurious signal rejection
- Improve dynamic range by increasing power, decreasing IF bandwidth, or averaging
- Trade off noise floor and measurement speed

10 MHz



26.5 GHz

Dynamic Range and Accuracy

ERROR DUE TO INTERFERING SIGNAL





VNA Block Diagram Examples

Basic 2 Port

Performance 4 Port

- Access loops & switches
- 2 sources & combiner
- Pulse modulation
- Noise tuner & LNA receiver
- Attenuators
- Bias-T's





Processor / Display



- Markers
- Limit lines
- Pass/fail indicators
- Linear/log formats
- Grid/polar/Smith charts
- Time-domain transform
- Trace math







Multiport Measurement Architectures

Application Examples

- RF front end modules / antenna switch modules
- Channel measurements of MIMO antennas
- Interconnects (ex. cables, connectors)
- General-purpose multiport devices

PXI Multiport VNA



PXI Multi-site VNA









Key Features

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- True multiport VNA with independent modules
- Improved throughput
- High performance without external switches
- Full N-port correction
- Reconfigurable to multiport or multisite



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Bandpass Filter four S-Parameters





Linear Versus Nonlinear Behavior



Linear behavior:

Input and output frequencies are the same (no additional frequencies created)

Output frequency only undergoes magnitude and phase change

Nonlinear behavior:

Output frequency may undergo frequency shift (e.g. with mixers) Additional frequencies created (harmonics, intermodulation)

For more information on linear vs. non-linear basics: http://literature.cdn.keysight.com/litweb/pdf/5965-7917E.pdf



Component Test Fundamentals

Gain Compression



- Parameter to define the transition between the linear and nonlinear region of an active device.
- The compression point is observed as x dB drop in the gain with VNA's power sweep.



Time vs. Frequency Domain

S11 RESPONSE OF SEMIRIGID COAX CABLE



- Why time domain?
 - Locate faults
 - Identify passive or inductive circuit elements
 - Identify and remove unwanted fixture responses
 - And more...

For more information on time domain basics: http://literature.cdn.keysight.com/litweb/pdf/5989-5723EN.pdf?id=923465



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The Need For Calibration

- Why do we have to calibrate?
 - It is impossible to make perfect hardware
 - It would be extremely difficult and expensive to make hardware good enough to entirely eliminate the need for error correction
- How do we get accuracy?
 - With vector-error-corrected calibration
 - Not the same as the yearly instrument calibration
- What does calibration do for us?
 - Removes the largest contributor to measurement uncertainty: systematic errors
 - Provides best picture of true performance of DUT





Measurement Error Modeling

Systematic Errors



- Due to imperfections in the analyzer and test setup
- Assumed to be time invariant (predictable)
- Generally, are largest sources or error

Random Errors

- Vary with time in random fashion (unpredictable)
- Main contributors: instrument noise, switch and connector repeatability

Drift Errors

- Due to system performance changing after a calibration has been done
- Primarily caused by temperature variation





Systematic Measurement Errors



Six forward and six reverse error terms yields 12 error terms for two-port devices



Types of Error Correction

Response (normalization)

- Simple to perform
- Only corrects for tracking (frequency response) errors
- Stores reference trace in memory, then does data divided by memory

Vector

- Requires more calibration standards
- Requires an analyzer that can measure phase
- Accounts for all major sources of systematic error





Available Standards

thru



Mechanical short, open, load, thru (SOLT)



Electronically switched arbitrary know impedances



Reflection: One-Port Vector Error Model



- To solve for error terms, we measure 3 standards to generate 3 equations and 3 unknowns
 - Assumes good termination at port two if testing two-port devices
 - If using port two of NA and DUT reverse isolation is low (e.g., filter passband):
 - Assumption of good termination is not valid
 - Two-port error correction yields better results

$$\begin{split} & \mathsf{E}_{\mathsf{D}} = \mathsf{Directivity} \\ & \mathsf{E}_{\mathsf{RT}} = \mathsf{Reflection\ tracking} \\ & \mathsf{E}_{\mathsf{S}} = \mathsf{Source\ Match} \\ & \mathsf{S11}_{\mathsf{M}} = \mathsf{Measured} \\ & \mathsf{S11}_{\mathsf{A}} = \mathsf{Actual} \end{split}$$

 $S_{11M} = E_D + E_{RT}$





Two Port 12-term Error Model Forward model

Ex Port 1 Port 2 S_{21A} ETT a₁ S_{11A} S22 E ERT S₁₂ $E_D = fwd directivity$ EL = fwd load match E_{TT} = fwd transmission tracking Es = fwd source match = fwd reflection tracking ERT

- $E_X =$ fwd isolation
- $E_{L'}$ = rev load match
- $E_{S'}$ = rev source match $E_{RT'}$ = rev reflection tracking

= rev directivity

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KEYSIGH

- $E_{TT'}$ = rev transmission tracking $E_{X'} = rev$ isolation
- Each actual S-parameter is a function of all four measured S-parameters
- Analyzer must make forward and reverse sweep to update any one S-parameter
- Luckily, you don't need to know these equations to use a network analyzer
- Crosstalk term, in most cases is not used



$$S_{11A} = \frac{S_{11N} \cdot (1 + S_{22N} \cdot ESR) - ELF \cdot S_{21N} \cdot S_{12N}}{(1 + S_{11N} \cdot ESF)(1 + S_{22N} \cdot ESR) - ELF \cdot ELR \cdot S_{21N} \cdot S_{12N}}$$

$$S_{21A} = \frac{S_{21N} \cdot (1 + S_{22N} \cdot [ESR - ELF])}{(1 + S_{11N} \cdot ESF)(1 + S_{22N} \cdot ESR) - ELF \cdot ELR \cdot S_{21N} \cdot S_{12N}}$$

$$S_{12A} = \frac{S_{12N} \cdot (1 + S_{11N} \cdot [ESF - ELR])}{(1 + S_{11N} \cdot ESF)(1 + S_{22N} \cdot ESR) - ELF \cdot ELR \cdot S_{21N} \cdot S_{12N}}$$

$$S_{22A} = \frac{S_{22N} \cdot \left(1 + S_{11N} \cdot ESF\right) - ELR \cdot S_{21N} \cdot S_{12N}}{\left(1 + S_{11N} \cdot ESF\right) \left(1 + S_{22N} \cdot ESR\right) - ELF \cdot ELR \cdot S_{21N} \cdot S_{12N}}$$

where a normalized S-parameter is defined as

 $S_{11N} = \frac{S_{11M} - EDF}{FPF}, \quad S_{21N} = \frac{S_{21M} - EXF}{FTF}, \quad S_{12N} = \frac{S_{12M} - EXR}{FTR}, \quad S_{22N} = \frac{S_{22M} - EDR}{FRR}$

Significance of Calibration

TYPES OF CALIBRATION

UNCORRECTED



- Convenient
- Generally not accurate
- No errors removed





- Easy to perform
- Use when highest accuracy is not required
- Removes frequency response error

ENHANCED RESPONSE

- Combines response and 1-port
- Corrects source match for transmission measurements

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1-PORT

| SHORT | |
|-------|--|
| OPEN | |
| LOAD | |

DUT

- For reflection measurements
- Need good termination for high accuracy with 2-port devices
- Removes these errors:
 - Directivity
 - Source match
 - Reflection tracking

FULL 2-PORT

| SHORT | | SHORT |
|-------|---------|-------|
| OPEN | | OPEN |
| LOAD | | LOAD |

Defined Thru or Unknown Thru



- Highest accuracy
- Removes these errors:
 - Directivity
 - Source/load match
 - Reflection tracking
 - Transmission tracking
 - Crosstalk (limited by noise)



Using Known Standards to Correct for Systematic Errors

Response calibration (normalization)

- Only one systematic error term measured
- Reflection tracking
- 1-port calibration (reflection measurements)
 - Only three systematic error terms measured
 - Directivity, source match, and reflection tracking

• Full two-port calibration (reflection and transmission measurements)

- Twelve systematic error terms measured
- 10 measurements on four known standards (SOLT)
- 7 measurements using Unknown Thru; 4 measurements using QSOLT

Standards defined in cal kit definition file

Network analyzer contains standard cal kit definitions

CAL KIT DEFINITION MUST MATCH ACTUAL CAL KIT USED!

User-built standards must be characterized and entered into user cal-kit **KEYSIGHT** TECHNOLOGIES



VNA showing Band Pass Filter

UNCALIBRATED, RESPONSE CAL AND FULL 2 PORT CAL

Measuring filter insertion loss





Vector Network Analyzers Product Portfolio

| Handł | 140 | Modular VNA | | | Benchtop VNA | | | Accessories | | | | |
|-----------------------------------|---|---|---|---|---|---|----------------|----------------------------|---|-------------|----------|--|
| FieldF Carry pro 30 k to 50 | Fox ecision with you 0 GHz | PX (Ms Hig Up On (Ms Driv Up t Broade | Performano beneformano to 9 GHz, max e-slot PXI V 37xA) re down the c to 26.5 GHz, m st Pric | ce VNA e PXI VNA c 24-ports WWWWWWWWWWWWWWWWWWWWWWWWWWWWWWWWWWWW | PNA Read 300 k E D 5 Tmanco | to 1.5 THz NA rive down the Hz to 20 GHz | e cost of test | Cal Up t Acc Swit | kits (Mec o 120 GHz cessories ich, Coupled wer mete | ch., E-Cal) | , tc. | |
| | | 2 | | Softwar | e Applio | cations | a 6 5 5 | | 4 | 9 5 | 59 12 | |
| | | | Ease-of-use, fundamental/advanced applications Common VNA software platform Flexibility in license types | | | | | | | | * | |
| | | ÷ | - | 30 | 18 | - | | - | 3 | 8 | | |
| | | | | | | | | * | | 8 | | |
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| | | | | | | ÷. | | | 3 | 2 | | |
| | | 2 | | | 25 | ÷); | | | | | | |
| | | | | Co | omponent Tes | t Fundamenta | IS | - | | | | |

Network Analyzer Measurement Resources

- Keysight RF and Digital Monthly Webcast Series <u>www.keysight.com/find/webcastseries</u>
 - Live and On Demand Viewing
 - Register for Future Webcasts
- Keysight RF Learning Center <u>www.keysight.com/find/klcrf</u>
 - Webcast Recordings
 - Application Notes
 - Understanding the Fundamentals of Network Analysis





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